Search Notes			

Applic	cation/Control No.	Applicant(s)/Patent under Reexamination	
10/80	9,106	LEE ET AL.	
Exam	iner	Art Unit	
Teena	a Mitchell	3743	

SEARCHED			
Class	Subclass	Date	Examiner
128	200.24 201.22 201.23 201.24	6/23/2005	ткм
	201,25		
	202.27		
	205,25		:
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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Inventors name search	6/23/2005	5 TKM	
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